



SPIE Digital Library

Proceedings

Journals

SPIE—The International Society for Optical Engineering

Home » Advanced Search » Search Results

SEARCH DIGITAL LIBRARY

Advanced Search

BROWSE PROCEEDINGS

- ▣ Proceedings
- ▣ By Year
- ▣ By Symposium
- ▣ By Volume No.
- ▣ By Volume Title
- ▣ By Technology

BROWSE JOURNALS

- ▣ Journals
- ▣ Optical Engineering
- ▣ J. Electronic Imaging
- ▣ J. Biomedical Optics
- ▣ J. Microolithography, Microfabrification, and Microsystems

SUBSCRIPTIONS & PRICING

- ▣ Institutions & Corporations
- ▣ Personal subscriptions

GENERAL INFORMATION

- ▣ About the Digital Library
- ▣ Terms of Use
- ▣ SPIE Home

[Back to Search Query | Start New Search | Searching Hints]

Search Results

You were searching for : (((image) <and>(morphological)) <and>(low pass))) <AND> usdate <=22-feb-2002
You found 1 out of 204808 (1 returned)
Documents 1 - 1 listed on this page

Options for selected Articles

Check Article(s) then ...

Adding to MyArticles will open a second window (Scitation login required).

[Related SPIE Products]

- 77%**
- ☐ **Comparison of multiresolution morphological and Laplacian techniques for automated inspection**
Jeffrey M. Seaton and A. Lynn Abbott
Proc. SPIE Int. Soc. Opt. Eng. **1708**, 789 (1992) **Full Text:** [PDF (557 KB)] (12 pages)



home | proceedings | journals

Terms of Use | Privacy Policy | Contact

© 1994 - 2005 The International Society for Optical Engineering

SPIE DL home | Scitation home | Search SPIN | help | contact | sign in | sign out

My SPIE Subscription | My E-mail Alerts | My Article Collections

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S83	0	(morphological\$2 with (low\$1pass LPF) with mask with enhanc\$5 with (chroma\$3 colo\$1r)).clm. <i>Interference Search</i>	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 14:23
S82	334	S81 and @pd>="20050801"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 14:08
S81	3139	S78 S79 S80	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 13:27
S80	1860	382/274,275.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 13:26
S79	862	348/607,618,619;358/3.21,3.24,3.27,447;708/300.ccls. and @pd>="20020101"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 13:26
S78	590	382/173,180,251,254,257,260-264,270-273.ccls. and @pd>="20050101"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 13:26
S1	1	US20030161547A1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/08 13:26
S77	1771	382/274,275.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 16:27
S76	784	348/607,618,619;358/3.21,3.24,3.27,447;708/300.ccls. and @pd>="20020101"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 16:26

S75	410	382/173,180,251,254,257, 260-264,270-273.ccls. and @pd>="20050101"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 16:06
S3	1961	348/607,618,619;358/3.21,3.24,3. 27,447;708/300.ccls. and @ad<"20020222"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 16:06
S2	4019	382/173,180,251,254,257, 260-264,270-273.ccls. and @ad<"20020222"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 16:05
S74	1	("6741753").URPN.	USPAT	OR	ON	2005/08/09 16:01
S73	6	("5224178" "5497431" "5838299" "6404918" "6453074" "6459436").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/08/09 16:00
S72	47	S68 with S71	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 15:40
S71	22640	(mask\$3 near4 (colo\$1r chrom\$4 hue))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 15:40
S70	115	S68 with S69	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 15:40
S69	37832	(mask\$3 with (colo\$1r chrom\$4 hue))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 15:40
S68	76651	((intensity (gr\$1y adj1 (level scale)) brightness luminance luma) near4 (correct\$3 modif\$7 enhanc\$5 adjust\$4))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/09 15:37